

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/039,324	RINDSBERG ET AL.		
Examiner	Art Unit		
DANH C. LE	2683		

SEARCHED						
Class	Subclass	Date	Examiner			
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375	221					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
Interfere	ince Search	11/30/05	DCL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Inventor Name Search EAST Search updated (USP, USPUB, EPO JPO DERWENT) Lee Nguyen (455) Vuong Hien (455)	11/30/05	DCL			